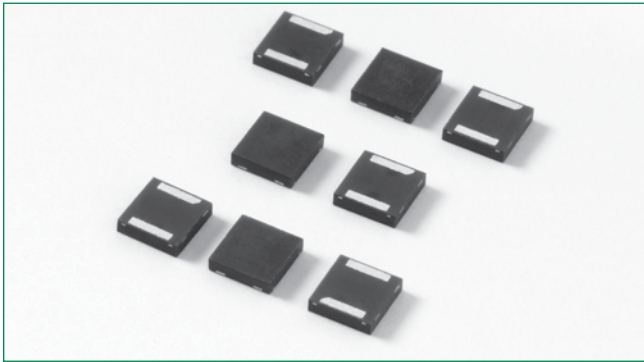



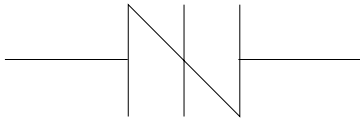
Q2L Series - 3.3x3.3 QFN



Agency Approvals

| Agency | Agency File Number |
|---|--------------------|
|  | E133083 |

Schematic Symbol



Additional Information



Datasheet



Resources



Samples

Description

Q2L Series 3.3x3.3 QFN are low capacitance SIDACtor[®] devices designed to protect high density broadband equipment from damaging overvoltage transients.

The series provides a low profile, chip scale surface mount solution that enables broadband equipment to comply with global regulatory standards while limiting the impact to broadband signals and board space.

Features and Benefits

- Low profile
- Small footprint
- Low capacitance
- Low voltage overshoot
- Low on-state voltage
- Does not degrade surge capability after multiple surge events within limit.
- Fails short circuit when surged in excess of ratings
- 2nd level interconnect is Pb-free per IPC/JEDEC J-STD-609A.01
- Recognized to UL 497B as an Isolated Loop Circuit Protector

Applicable Global Standards

- TIA-968-A
- TIA-968-B
- ITU K.20/21 Enhanced Level
- ITU K.20/21 Basic Level
- GR 1089 Inter-building
- GR 1089 Intra-building
- IEC 61000-4-5
- YD/T 1082
- YD/T 993
- YD/T 950

Electrical Characteristics

| Part Number | Marking | V_{DRM} @ $I_{DRM} = 5\mu A$ | V_S @ $100V/\mu s$ | I_H | I_S | I_T | $V_T @ I_T = 2.2 \text{ Amps}$ | Capacitance @ 1MHz, 2V bias | |
|--------------|---------|-----------------------------------|-------------------------|--------|--------|-------|--------------------------------|--------------------------------|--------|
| | | V min | V max | mA min | mA max | A max | V max | pF min | pF max |
| P0080Q22CLRP | P-8C | 6 | 25 | 50 | 800 | 2.2 | 5 | 35 | 75 |
| P0300Q22CLRP | P03C | 25 | 40 | 50 | 800 | 2.2 | 5 | 25 | 45 |
| P0640Q22CLRP | P06C | 58 | 77 | 150 | 800 | 2.2 | 5 | 55 | 85 |
| P0720Q22CLRP | P07C | 65 | 88 | 150 | 800 | 2.2 | 5 | 50 | 75 |
| P0900Q22CLRP | P09C | 75 | 98 | 150 | 800 | 2.2 | 5 | 45 | 70 |
| P1100Q22CLRP | P11C | 90 | 130 | 150 | 800 | 2.2 | 5 | 45 | 70 |
| P1200Q22CLRP | P12C | 100 | 130 | 150 | 800 | 2.2 | 5 | 45 | 70 |
| P1300Q22CLRP | P13C | 120 | 160 | 150 | 800 | 2.2 | 5 | 40 | 60 |
| P1500Q22CLRP | P15C | 140 | 180 | 150 | 800 | 2.2 | 5 | 35 | 55 |
| P1800Q22CLRP | P18C | 170 | 220 | 150 | 800 | 2.2 | 5 | 35 | 50 |
| P2000Q22CLRP | P20C | 180 | 220 | 150 | 800 | 2.2 | 5 | 30 | 50 |
| P2300Q22CLRP | P23C | 190 | 260 | 150 | 800 | 2.2 | 5 | 30 | 50 |
| P2500Q22CLRP | P25C | 230 | 290 | 150 | 800 | 2.2 | 5 | 30 | 50 |
| P2600Q22CLRP | P26C | 220 | 300 | 150 | 800 | 2.2 | 5 | 30 | 45 |
| P3100Q22CLRP | P31C | 275 | 350 | 150 | 800 | 2.2 | 5 | 30 | 45 |
| P3500Q22CLRP | P35C | 320 | 400 | 150 | 800 | 2.2 | 5 | 25 | 40 |
| P4500Q22CLRP | P45C | 400 | 530 | 150 | 800 | 2.2 | 5 | 25 | 45 |

Notes:

- Absolute maximum ratings measured at $T_A = 25^\circ C$ (unless otherwise noted).
- Devices are bi-directional (unless otherwise noted).


Surge Ratings

| Series | 2x10 ¹ | 8x20 ¹ | 10x160 ¹ | 10x560 ¹ | 10x1000 ¹ | 5x310 ¹ | I _{TSM} | di/dt |
|--------|-------------------|---------------------|---------------------|---------------------|----------------------|---------------------|------------------|----------|
| | 2x10 ² | 1.2x50 ² | 10x160 ² | 10x560 ² | 10x1000 ² | 10x700 ² | 50/60 Hz | A/μs max |
| | A min | A min | A min | A min | A min | A min | A min | A/μs max |
| C | 500 | 400 | 200 | 150 | 100 | 200 ³ | 30 | 500 |

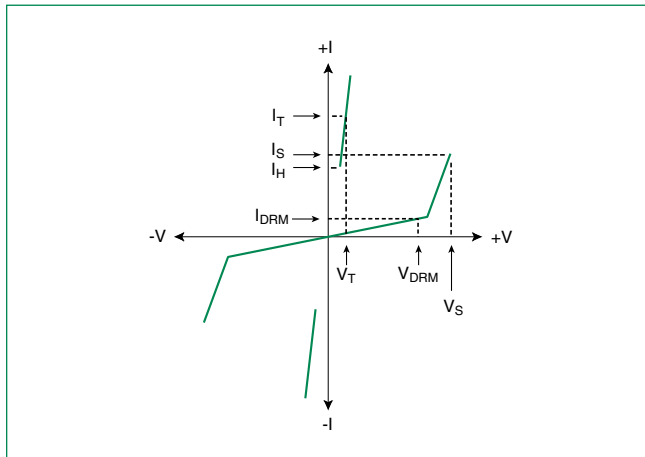
Notes:

1. Current waveform in μs
 2. Voltage waveform in μs
 3. For surge rating of P4500Q22CLRP 10x700μs min=150A & typical=180A
- Peak pulse current rating (I_{pp}) is repetitive and guaranteed for the life of the product.
 - I_{pp} ratings applicable over temperature range of -40°C to +85°C
 - The device must initially be in thermal equilibrium with -40°C ≤ T_j ≤ +150°C

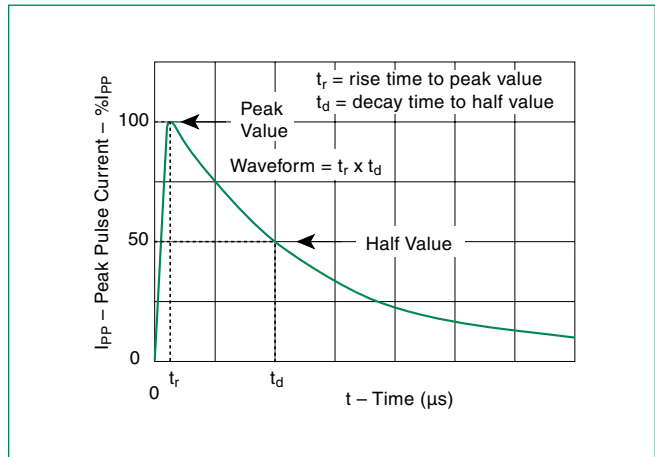
Thermal Considerations

| Package | Symbol | Parameter | Value | Unit |
|--|------------------|---|-------------|------|
| 3.3 x 3.3 QFN  | T _J | Operating Junction Temperature Range | -40 to +150 | °C |
| | T _S | Storage Temperature Range | -65 to +150 | °C |
| | R _{θJA} | Thermal Resistance: Junction to Ambient | 120 | °C/W |

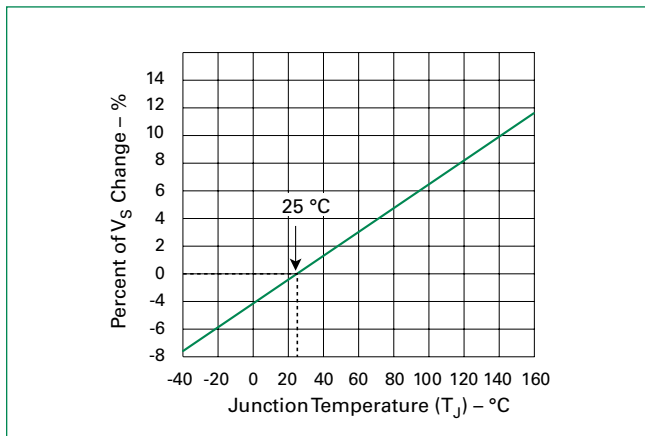
V-I Characteristics



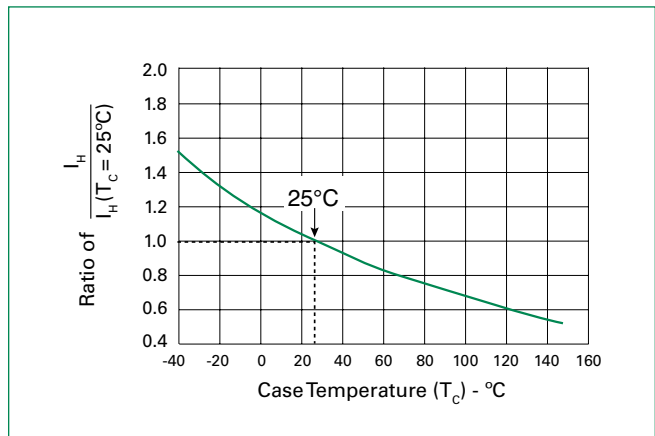
t_r x t_d Pulse Waveform



Normalized V_S Change vs. Junction Temperature

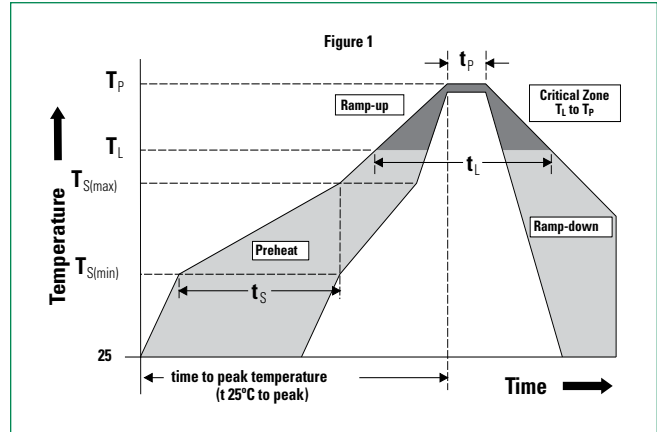


Normalized DC Holding Current vs. Case Temperature



Soldering Parameters

| | | |
|--|------------------------------------|------------------|
| Reflow Condition | | Pb-Free assembly |
| Pre Heat | - Temperature Min ($T_{s(min)}$) | +150°C |
| | - Temperature Max ($T_{s(max)}$) | +200°C |
| | - Time (Min to Max) (t_s) | 60-180 secs. |
| Average ramp up rate (Liquidus Temp (T_L) to peak) | | 3°C/sec. Max. |
| $T_{s(max)}$ to T_L - Ramp-up Rate | | 3°C/sec. Max. |
| Reflow | - Temperature (T_L) (Liquidus) | +217°C |
| | - Temperature (t_L) | 60-150 secs. |
| Peak Temp (T_p) | | +260(+0/-5)°C |
| Time within 5°C of actual Peak Temp (t_p) | | 30 secs. Max. |
| Ramp-down Rate | | 6°C/sec. Max. |
| Time 25°C to Peak Temp (T_p) | | 8 min. Max. |
| Do not exceed | | +260°C |



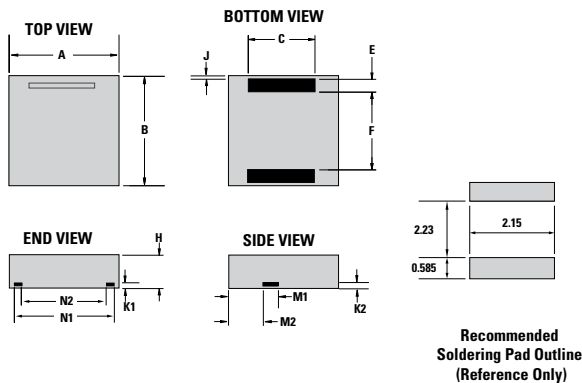
Physical Specifications

| | |
|------------------------|---|
| Lead Material | Copper Alloy |
| Terminal Finish | 100% Matte-Tin Plated |
| Body Material | UL recognized epoxy meeting flammability classification 94V-0 |

Environmental Specifications

| | |
|-----------------------------------|--|
| High Temp Voltage Blocking | 80% Rated V_{DRM} ($V_{AC Peak}$) +125°C or +150°C, 504 or 1008 hrs. MIL-STD-750 (Method 1040) JEDEC, JESD22-A-101 |
| Temp Cycling | -65°C to +150°C, 15 min. dwell, 10 up to 100 cycles. MIL-STD-750 (Method 1051) EIA/JEDEC, JESD22-A-104 |
| Biased Temp & Humidity | 52 V_{DC} (+85°C) 85%RH, 504 up to 1008 hrs. EIA/JEDEC, JESD22-A-101 |
| High Temp Storage | +150°C 1008 hrs. MIL-STD-750 (Method 1031) JEDEC, JESD22-A-101 |
| Low Temp Storage | -65°C, 1008 hrs. |
| Thermal Shock | 0°C to +100°C, 5 min. dwell, 10 sec. transfer, 10 cycles. MIL-STD-750 (Method 1056) JEDEC, JESD22-A-106 |
| Resistance to Solder Heat | +260°C, 30 secs. MIL-STD-750 (Method 2031) |
| Moisture Sensitivity Level | 85%RH, +85°C, 168 hrs., 3 reflow cycles (+260°C Peak). JEDEC-J-STD-020, Level 1 |

Dimensions — 3.3x3.3 QFN



| Dimensions | Inches | | Millimeters | |
|------------|--------|-------|-------------|-------|
| | Min | Max | Min | Max |
| A | 0.126 | 0.134 | 3.200 | 3.400 |
| B | 0.126 | 0.134 | 3.200 | 3.400 |
| C | 0.075 | 0.083 | 1.900 | 2.100 |
| E | 0.011 | 0.019 | 0.285 | 0.485 |
| F | 0.088 | 0.096 | 2.230 | 2.430 |
| H | 0.035 | 0.043 | 0.900 | 1.100 |
| J | 0.000 | 0.008 | 0.000 | 0.200 |
| K1 | 0.004 | 0.012 | 0.100 | 0.300 |
| K2 | 0.004 | 0.012 | 0.100 | 0.300 |
| M1 | 0.063 | 0.071 | 1.610 | 1.810 |
| M2 | 0.045 | 0.053 | 1.153 | 1.353 |
| N1 | 0.095 | 0.103 | 2.420 | 2.620 |
| N2 | 0.082 | 0.090 | 2.080 | 2.280 |